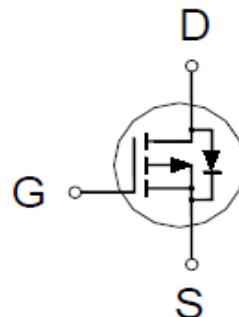
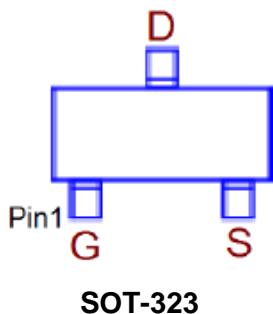


PZ513BA

P-Channel Enhancement Mode MOSFET

PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
-20V	115mΩ @ $V_{GS} = -4.5V$	-1.3A



ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ C$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS	SYMBOL	LIMITS	UNITS
Drain-Source Voltage	V_{DS}	-20	V
Gate-Source Voltage	V_{GS}	± 8	
Continuous Drain Current	I_D	-1.3	A
		-1	
Pulsed Drain Current ¹	I_{DM}	-10	
Power Dissipation	P_D	0.3	W
		0.2	
Junction & Storage Temperature Range	T_J, T_{STG}	-55 to 150	°C

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient ²	$R_{\theta JA}$		360	°C / W

¹limited by maximum junction temperature.

²The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ C$.



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ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$, Unless Otherwise Noted)

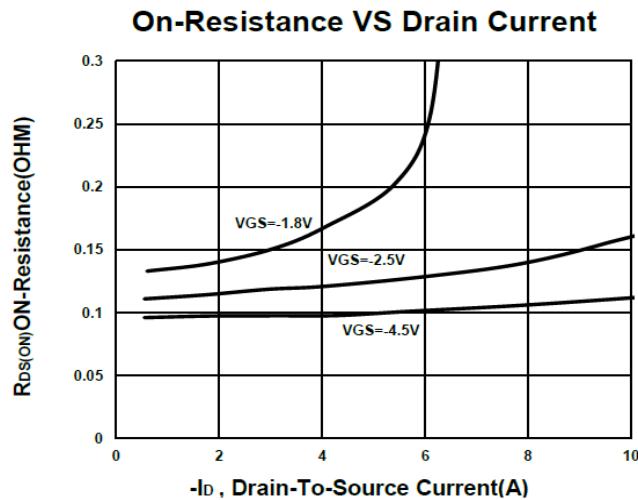
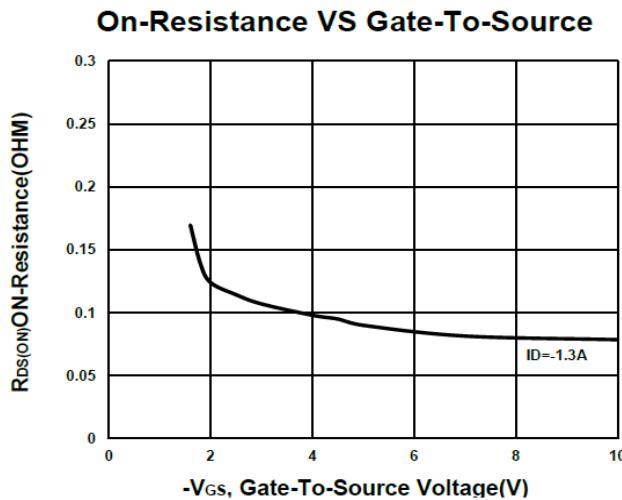
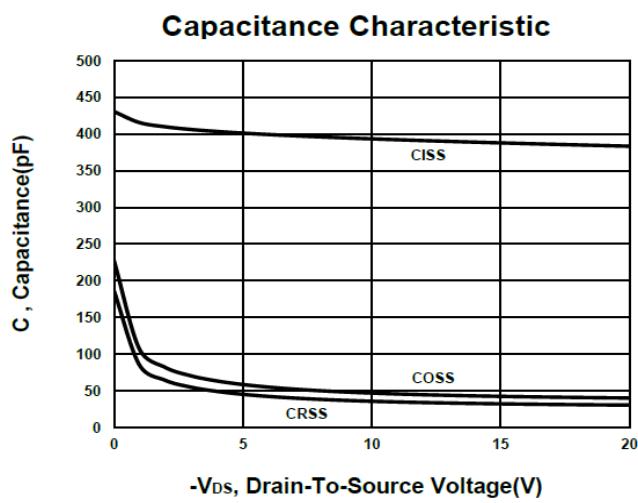
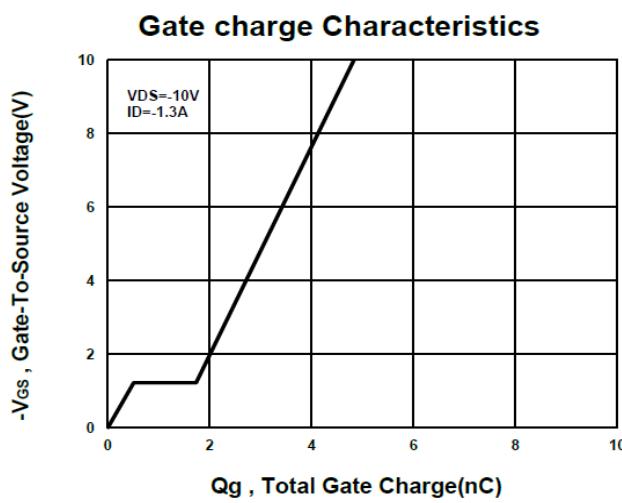
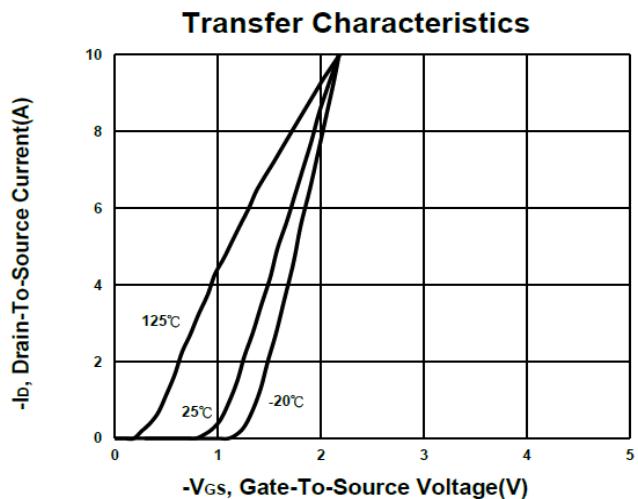
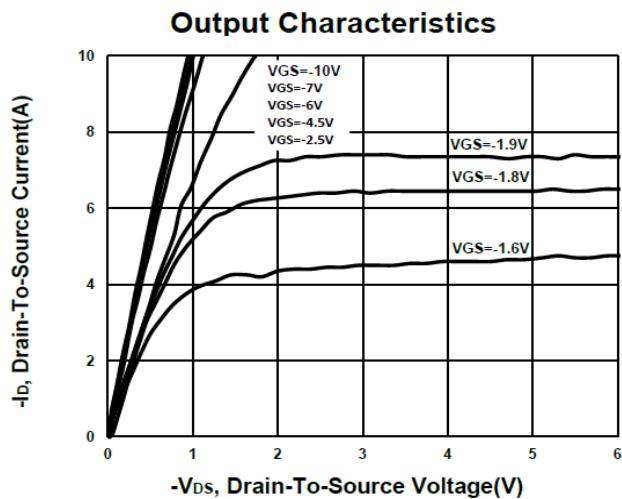
PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNITS
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = -250\mu\text{A}$	-20			V
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = -250\mu\text{A}$	-0.3	-0.65	-1	
Gate-Body Leakage	I_{GSS}	$V_{\text{DS}} = 0\text{V}, V_{\text{GS}} = \pm 8\text{V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}} = -16\text{V}, V_{\text{GS}} = 0\text{V}$			-1	μA
		$V_{\text{DS}} = -10\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 70^\circ\text{C}$			-10	
Drain-Source On-State Resistance ¹	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}} = -1.8\text{V}, I_D = -1\text{A}$		141	190	$\text{m}\Omega$
		$V_{\text{GS}} = -2.5\text{V}, I_D = -1\text{A}$		116	130	
		$V_{\text{GS}} = -4.5\text{V}, I_D = -1.3\text{A}$		97	115	
Forward Transconductance ¹	g_{fs}	$V_{\text{DS}} = -5\text{V}, I_D = -1.3\text{A}$		7		S
DYNAMIC						
Input Capacitance	C_{iss}	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = -10\text{V}, f = 1\text{MHz}$		414		pF
Output Capacitance	C_{oss}			47		
Reverse Transfer Capacitance	C_{rss}			36		
Total Gate Charge ²	$Q_g(V_{\text{GS}}=-4.5\text{V})$	$V_{\text{DS}} = -10\text{V}, I_D = -1.3\text{A}, V_{\text{GS}} = -4.5\text{V}$		4.9		nC
	$Q_g(V_{\text{GS}}=-2.5\text{V})$			3		
Gate-Source Charge ²	Q_{gs}			0.6		
Gate-Drain Charge ²	Q_{gd}			1.3		
Turn-On Delay Time ²	$t_{\text{d(on)}}$	$V_{\text{DS}} = -10\text{V}, I_D \geq -1.3\text{A}, V_{\text{GS}} = -4.5\text{V}, R_{\text{GEN}} = 6\Omega$		9.4		nS
Rise Time ²	t_r			38		
Turn-Off Delay Time ²	$t_{\text{d(off)}}$			60		
Fall Time ²	t_f			66		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_J = 25^\circ\text{C}$)						
Continuous Current	I_S				-0.25	A
Forward Voltage ¹	V_{SD}	$I_F = -1.3\text{A}, V_{\text{GS}} = 0\text{V}$			-1.2	V
Reverse Recovery Time	t_{rr}	$I_F = -1.3\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		8		nS
Reverse Recovery Charge	Q_{rr}			3		nC

¹Pulse test : Pulse Width $\leq 300\ \mu\text{sec}$, Duty Cycle $\leq 2\%$.

²Independent of operating temperature.

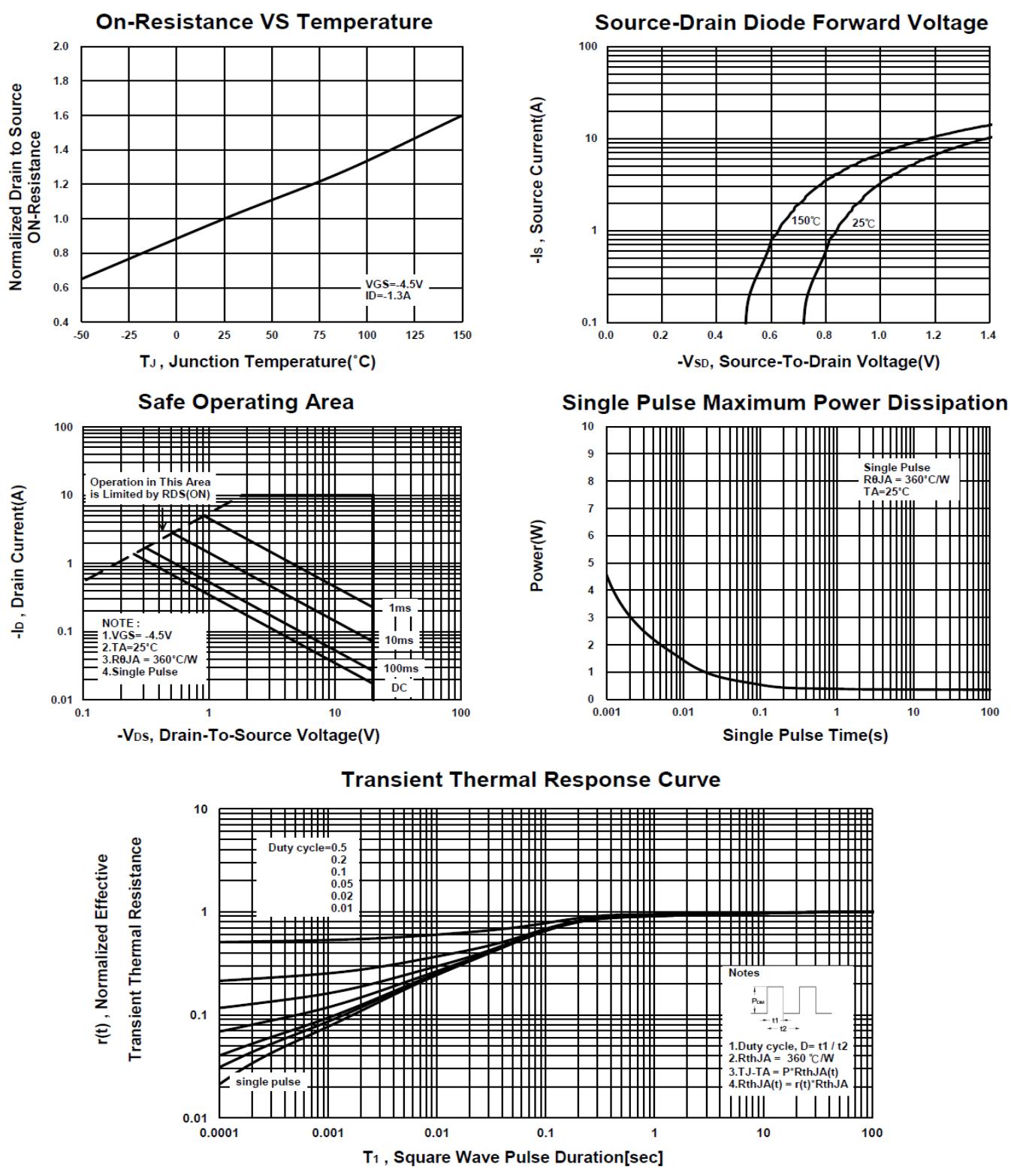
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Package Dimension

SOT-323 MECHANICAL DATA

Dimension	mm			Dimension	mm		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A		0.65		H	0.08		0.25
B	1.80		2.45	I	0.15		0.46
C	1.15		1.35	J			
D	1.80		2.20	K			
E	0.80		1.00	L			
F	0.00		0.10	M			
G	0.20		0.40	N			

